



## FAN7382

### Half-Bridge Gate Driver (SOURCING/SINKING : 350mA/650mA)

#### Features

- Floating Channel Designed For Bootstrap Operation To +600V.
- Typically 350mA/650mA Sourcing/Sinking Current Driving Capability For Both Channels
- Common-Mode dv/dt Noise Canceling Circuit
- Extended Allowable Negative VS Swing To -9V For Signal Propagation @ VCC=VBS=15V
- VCC & VBS Supply Range From 10V To 20V
- UVLO Functions For Both Channels
- TTL Compatible Input Logic Threshold Levels
- Matched Propagation Delay Below 50nsec
- Output In-phase With Input

#### Description

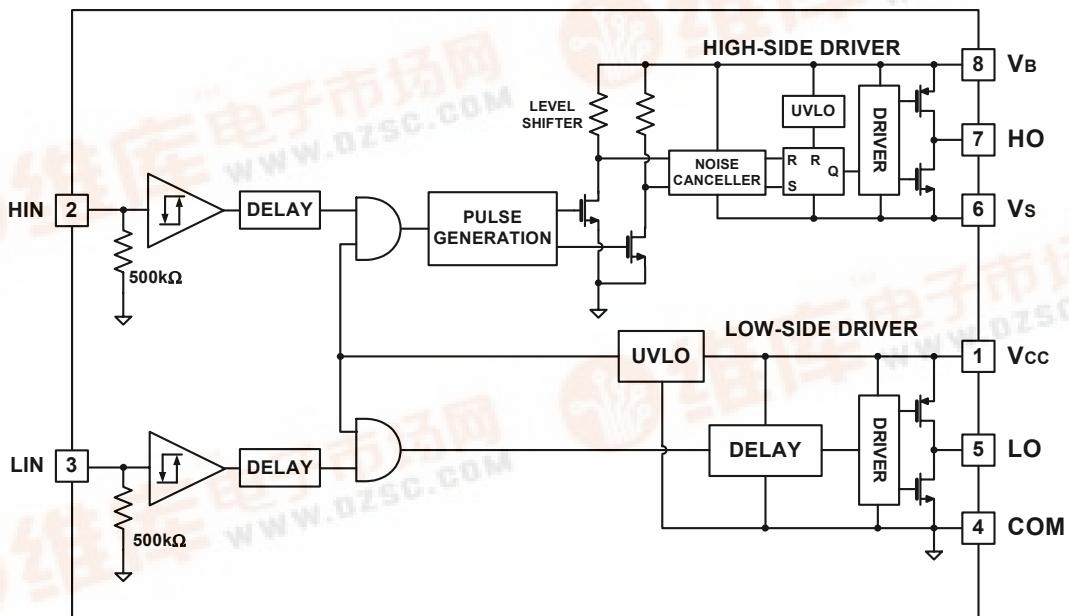
The FAN7382 is a monolithic half-bridge gate driver IC for driving MOSFETs and IGBTs, which operate up to +600V. Fairchild's high voltage process and common-mode noise canceling technique give stable operation of high-side driver under high dv/dt noise circumstances. Advanced level shift circuit allows high-side gate driver operation up to VS=-9.8 V(typ.) for VBS=15V. The input logic level is compatible with standard TTL series logic gates. UVLO circuits for both channels prevent malfunction when VCC and VBS are lower than the specified threshold voltage. Output drivers typically source/sink 350mA/650mA, respectively, which is suitable for the applications such as fluorescent lamp ballast, PDP scan driver, motor control, etc.

#### Typical Applications

- PDP Scan Driver
- Fluorescent Lamp Ballast

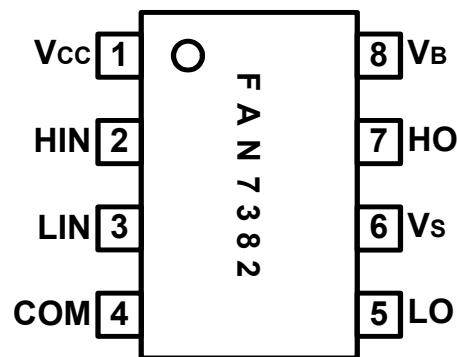


#### Internal Block Diagram



Rev. 0.0.3

## Pin Assignments



## Pin Descriptions

Pin No	Symbol	I/O	Description
1	VCC		Low Side Supply Voltage
2	HIN		Logic Input for High Side Gate Driver Output
3	LIN		Logic Input for Low Side Gate Driver Output
4	COM		Logic Ground and Low Side Driver Return
5	LO		Low Side Driver Output
6	VS		High Voltage Floating Supply Return
7	HO		High Side Driver Output
8	VB		High Side Floating Supply

## Absolute Maximum Ratings

Parameter	Symbol	Min.	Typ.	Max.	Unit
High side offset Voltage	V <sub>S</sub>	V <sub>BS</sub> -25	-	V <sub>BS</sub> +0.3	V
High side floating supply voltage	V <sub>B</sub>	-0.3		625	
High side floating output voltage HO	V <sub>HO</sub>	V <sub>S</sub> -0.3		V <sub>B</sub> +0.3	
Low side and logic fixed supply voltage	V <sub>CC</sub>	-0.3		25	
Low side output voltage LO	V <sub>LO</sub>	-0.3		V <sub>CC</sub> +0.3	
Logic input voltage(HIN, LIN)	V <sub>IN</sub>	-0.3		V <sub>CC</sub> +0.3	
Logic Ground	Com	V <sub>CC</sub> -25		V <sub>CC</sub> +0.3	
Allowable offset voltage SLEW RATE	dV <sub>s</sub> /dt			50	V/ns
Power Dissipation	P <sub>D</sub>			0.625	W
Thermal resistance, junction to ambient	R <sub>thja</sub>			200	°C/W
Junction Temperature	T <sub>J</sub>			150	°C
Storage Temperature	T <sub>S</sub>			150	°C

Note : Absolute maximum ratings indicate sustained limits beyond which damage to the device may occur. All voltage parameters are absolute voltage referenced to COM, all currents are defined positive into any lead.

## Recommended Operating Ratings

Parameter	Symbol	Min.	Typ.	Max.	Unit
High side floating supply voltage	V <sub>B</sub>	V <sub>S</sub> +10	-	V <sub>S</sub> +20	V
High side floating supply offset voltage	V <sub>S</sub>	6-V <sub>CC</sub>		600	
High side(HO) output voltage	V <sub>HO</sub>	V <sub>S</sub>		V <sub>B</sub>	
Low side(LO) output voltage	V <sub>LO</sub>	COM		V <sub>CC</sub>	
Logic input voltage(HIN, LIN)	V <sub>IN</sub>	COM		V <sub>CC</sub>	
Low side supply voltage	V <sub>CC</sub>	10		20	
Ambient Temperature	T <sub>A</sub>	-40		125	

## ESD Level

Parameter	Plns	Conditions	Level	Unit
Human Body Model(HBM)	V <sub>CC</sub> ,COM,HIN,LIN,LO	R=1.5kΩ, C=100pF	±2,000	V
	VB,HO,VS		±1,500	
Machine Model(MM)	V <sub>CC</sub> ,COM,HIN,LIN, VB,HO,VS	C=200pF	±300	V
	LO		±200	
Charged Device Model(CDM)	All Pins		±500	

## Static Electrical Characteristics

(V<sub>BIAS</sub>(VCC, VBS)=15.0V, TA = 25°C, unless otherwise specified. The V<sub>IN</sub>, V<sub>TH</sub> and I<sub>IN</sub> parameters are referenced to COM. The V<sub>O</sub> and I<sub>O</sub> parameters are referenced to COM and V<sub>S</sub> is applicable to HO and LO.)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
VCC and VBS supply undervoltage positive going threshold	V <sub>CCUV+</sub> V <sub>B SUV+</sub>		8.2	9.2	10.0	V
VCC and VBS supply undervoltage negative going threshold	V <sub>CCUV-</sub> V <sub>B SUV-</sub>		7.6	8.7	9.6	
VCC supply undervoltage lockout hysteresis	V <sub>CCUVH</sub> V <sub>B SUVH</sub>		-	0.6	-	
Offset supply leakage current	I <sub>LK</sub>	V <sub>B</sub> =V <sub>S</sub> =600V	-	-	50	uA
Quiescent VBS supply current	I <sub>QBS</sub>	V <sub>IN</sub> =0V or 5V	-	45	120	
Quiescent VCC supply current	I <sub>QCC</sub>	V <sub>IN</sub> =0V or 5V	-	70	180	
Operating VBS supply current	I <sub>PBS</sub>	f <sub>in</sub> =20kHz,rms value	-	-	600	uA
Operating VCC supply current	I <sub>PC</sub>	f <sub>in</sub> =20kHz,rms value	-	-	600	
Logic "1" input voltage	V <sub>IH</sub>	IO=20mA	2.9	-	-	V
Logic "0" input voltage	V <sub>IL</sub>		-	-	0.8	
High level output voltage, V <sub>BIAS</sub> -VO	V <sub>OH</sub>		-	-	1.0	
Low level output voltage, VO	V <sub>OL</sub>		-	-	0.6	
Logic "1" input bias current	I <sub>IN+</sub>	V <sub>IN</sub> =5V	-	10	20	uA
Logic "0" input bias current	I <sub>IN-</sub>	V <sub>IN</sub> =0V	-	1.0	2.0	
Output high short circuit pulse current	I <sub>O+</sub>	V <sub>O</sub> =0V PW<10us	250	350	-	mA
Output low short circuit pulsed current	I <sub>O-</sub>	V <sub>O</sub> =V <sub>B</sub> , PW<10us	500	650	-	
Allowable negative V <sub>S</sub> pin voltage for HIN signal propagation to HO	V <sub>S</sub>		-	-9.8	-7	V

## Dynamic Electrical Characteristics

(V<sub>BIAS</sub>(VCC, VBS)=15.0V, V<sub>S</sub>=COM, C<sub>L</sub>=1000pF and TA = 25°C, unless otherwise specified.)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Turn-on propagation delay	t <sub>on</sub>	V <sub>S</sub> =0V	100	170	300	ns
Turn-off propagation delay	t <sub>off</sub>	V <sub>S</sub> =0V or 600V	100	200	300	
Turn-on rise time	t <sub>r</sub>		20	60	140	
Turn-off fall time	t <sub>f</sub>		-	30	80	
Delay matching, HS & LS turn-on/off	MT		-	-	50	

## Typical Characteristics

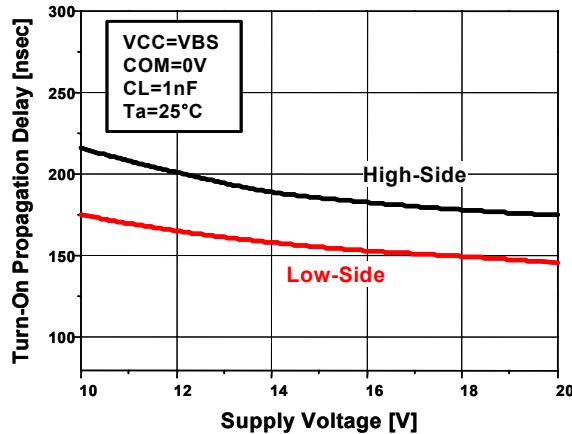


Fig. 1 Turn-On Propagation Delay vs. Supply Voltage

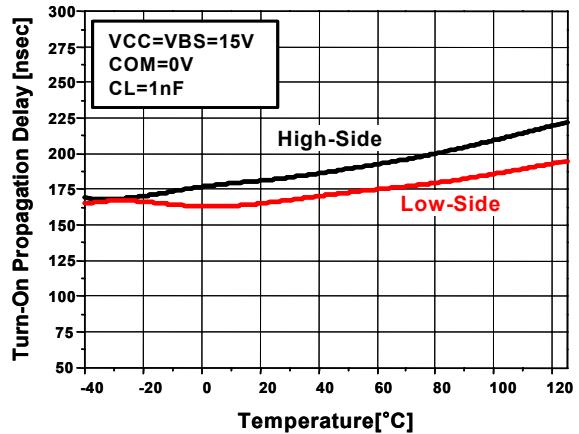


Fig. 2 Turn-On Propagation Delay vs. Temperature

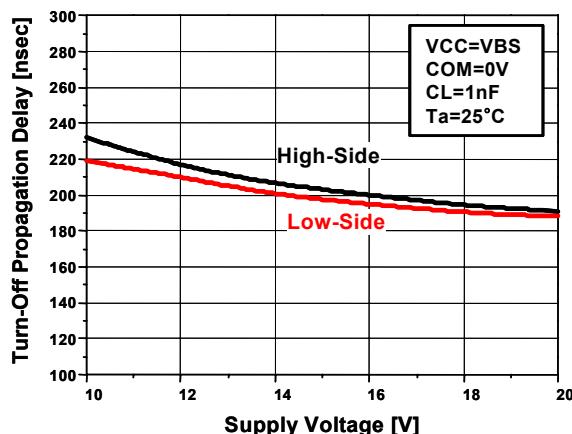


Fig. 3 Turn-Off Propagation Delay vs. Supply Voltage

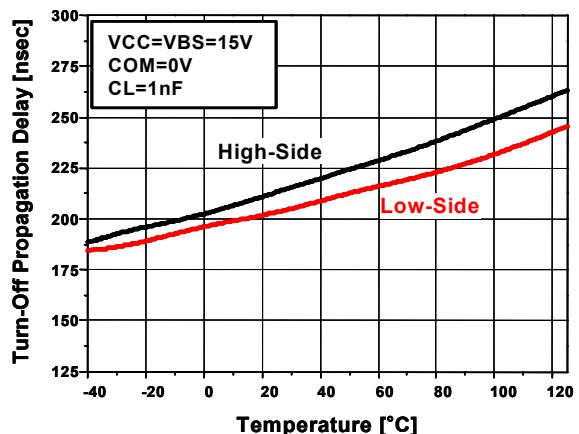


Fig. 4 Turn-Off Propagation Delay vs. Temperature

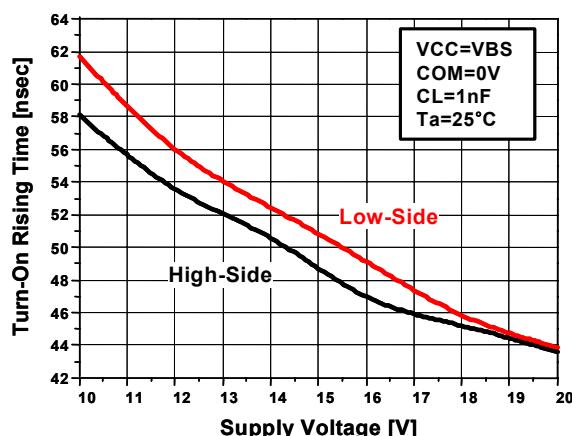


Fig. 5 Turn-On Rising Time vs. Supply Voltage

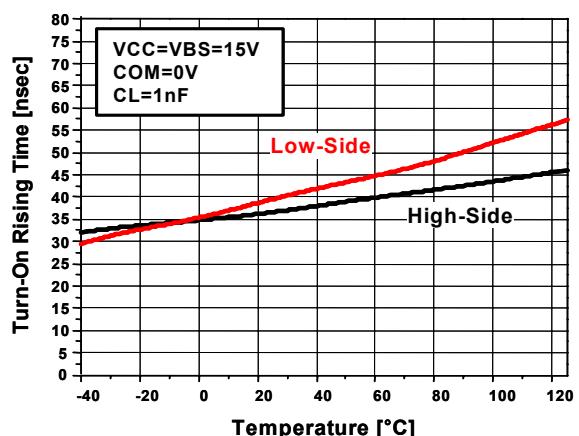


Fig. 6 Turn-On Rising Time vs. Temperature

## Typical Characteristics(cont')

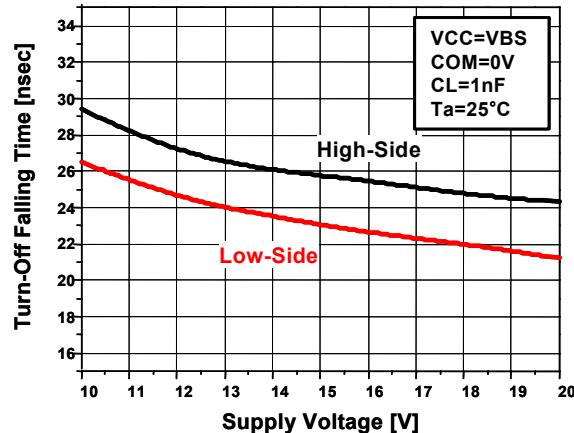


Fig. 7 Turn-Off Falling Time vs. Supply Voltage

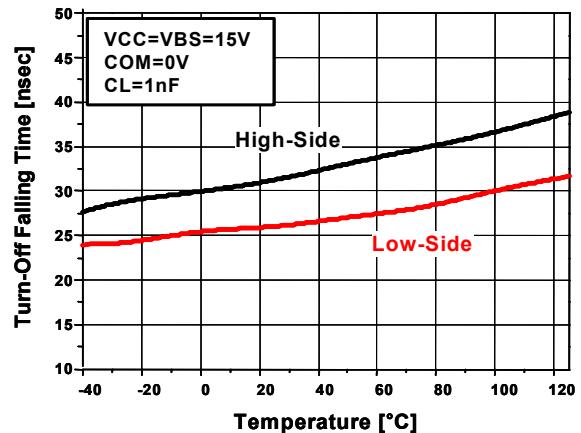


Fig. 8 Turn-Off Falling Time vs. Temperature

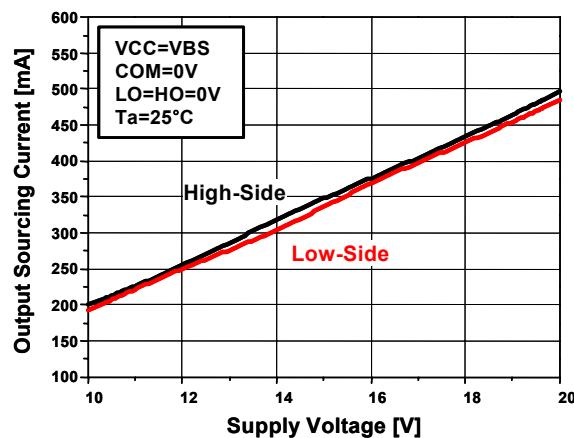


Fig. 9 Output Sourcing Current vs. Supply Voltage

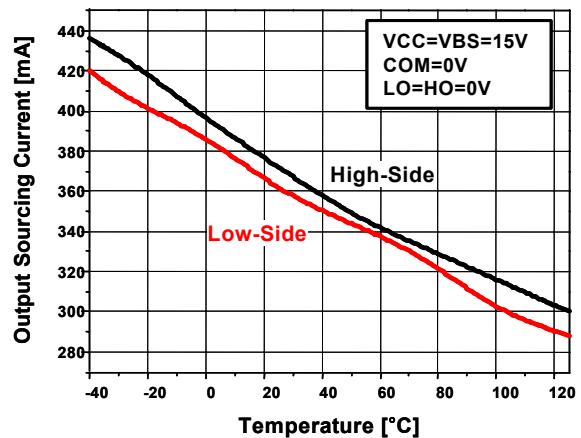


Fig. 10 Output Sourcing Current vs. Temperature

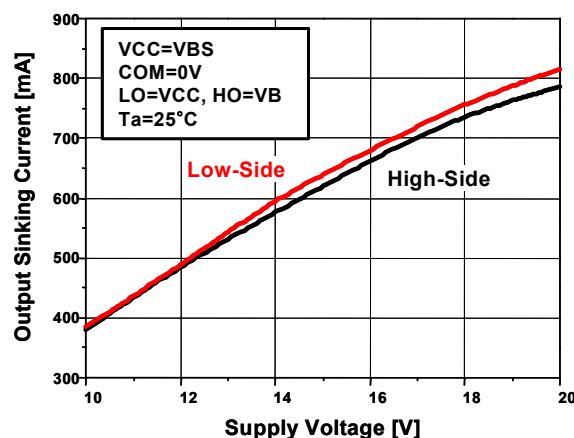


Fig. 11 Output Sinking Current vs. Supply Voltage

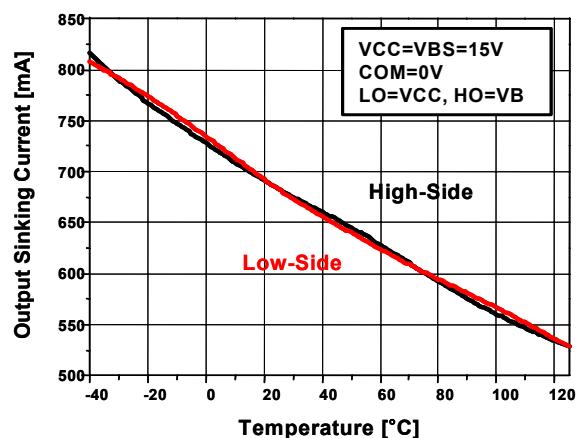


Fig. 12 Output Sinking Current vs. Temperature

## Typical Characteristics

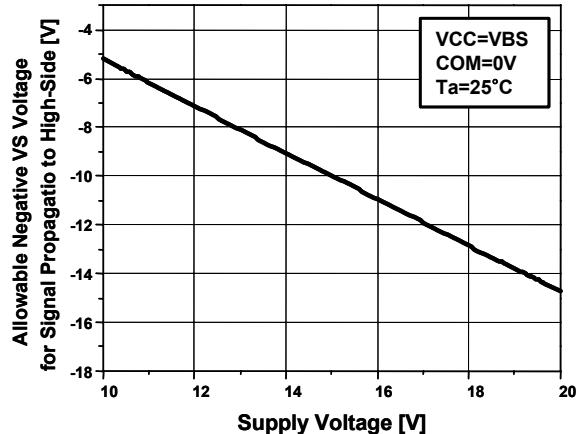


Fig. 13 Allowable Negative VS Voltage for Signal Propagation to High Side vs. Supply Voltage

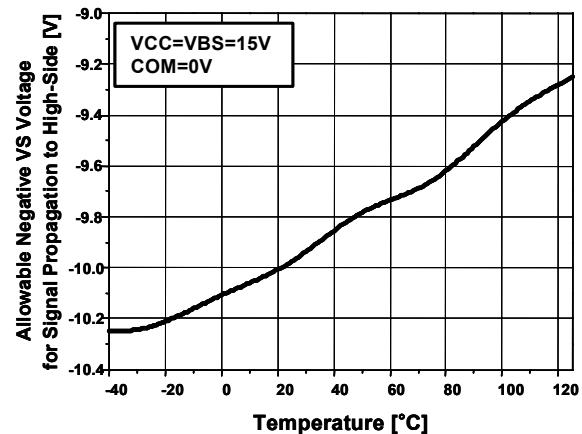


Fig. 14 Allowable Negative VS Voltage for Signal Propagation to High Side vs. Temperature

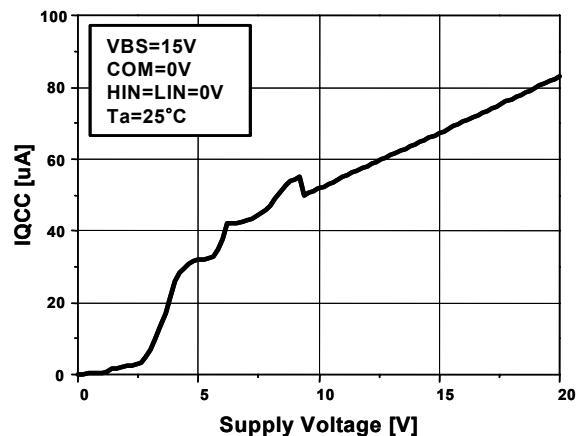


Fig. 15 IQCC vs. Supply Voltage

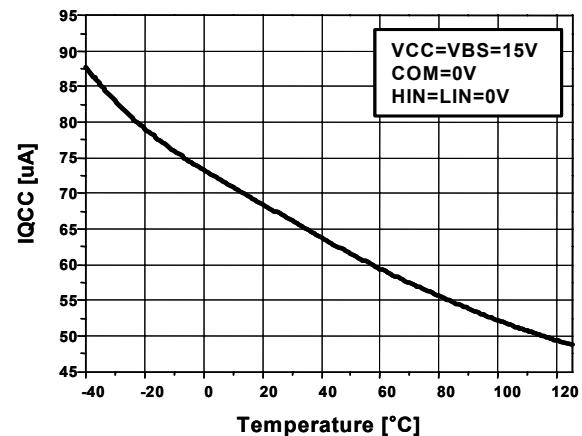


Fig. 16 IQCC vs. Temperature

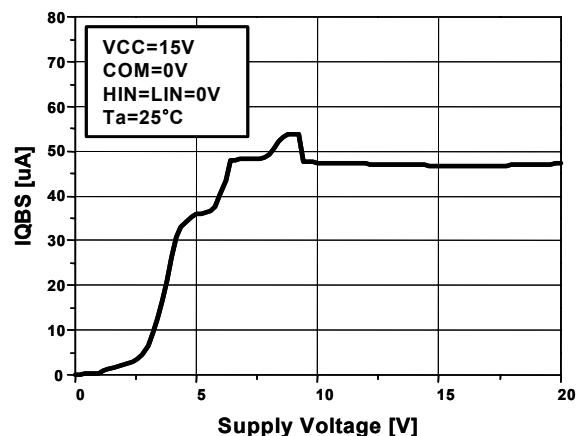


Fig. 17 IQBS vs. Supply Voltage

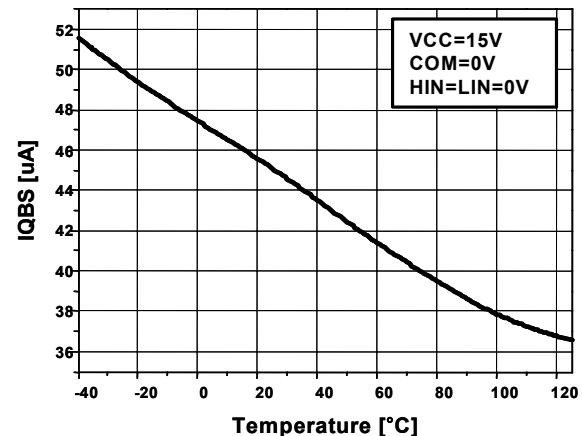


Fig. 18 IQBS vs. Temperature

## Typical Characteristics

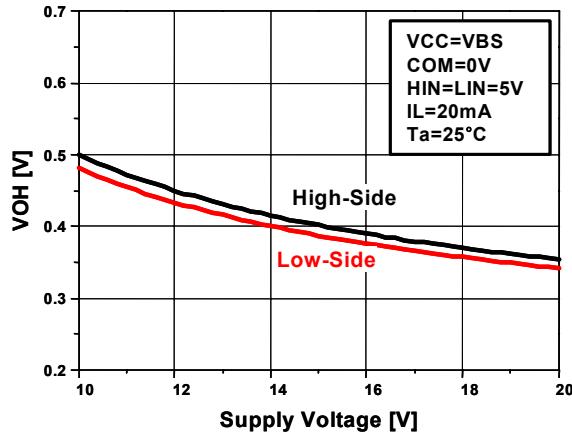


Fig. 19 High Level Output Voltage vs. Supply Voltage

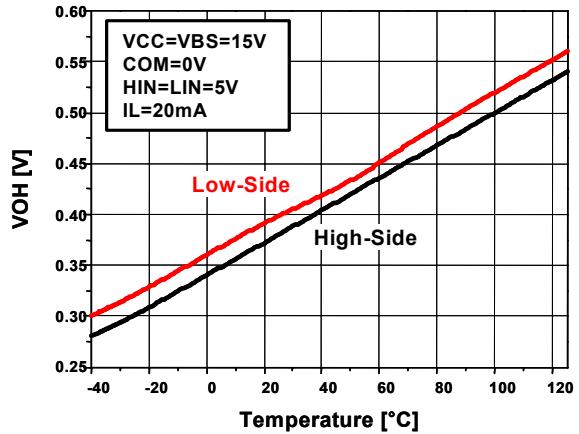


Fig. 20 High Level Output Voltage vs. Temperature

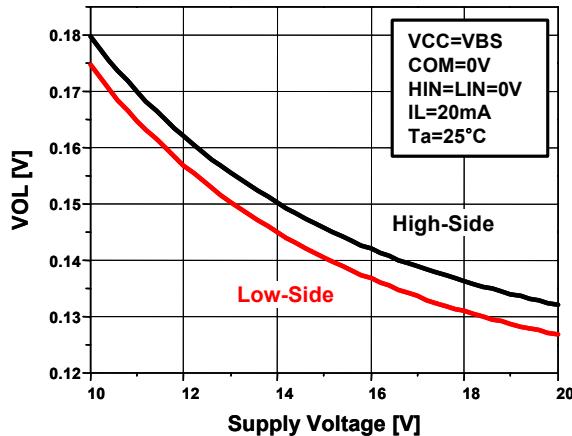


Fig. 21 Low Level Output Voltage vs. Supply Voltage

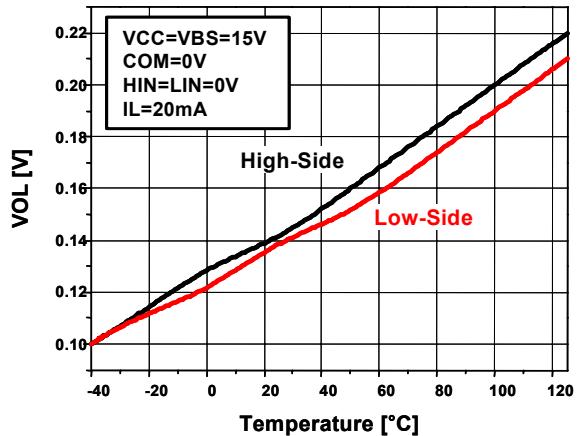


Fig. 22 Low Level Output Voltage vs. Temperature

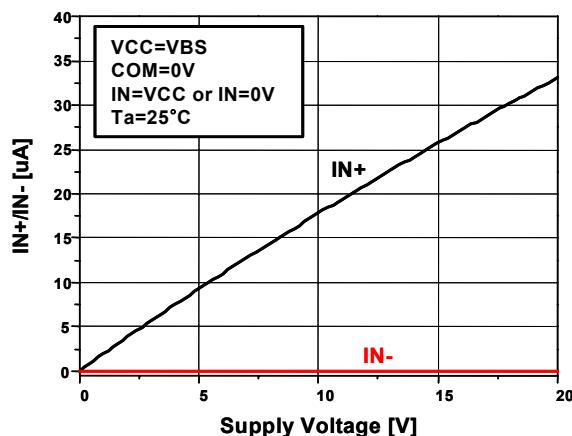


Fig. 23 Input Bias Current vs. Supply Voltage

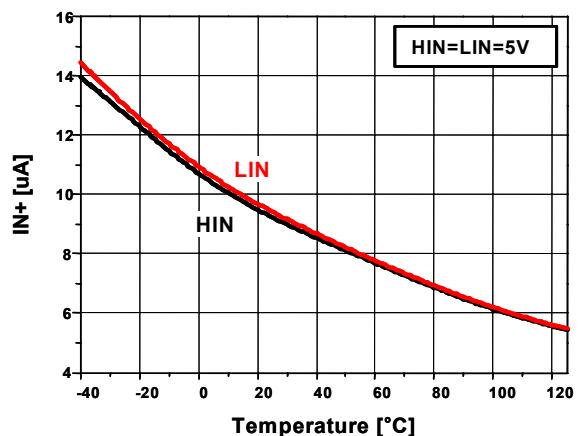


Fig. 24 Input Bias Current vs. Temperature

## Typical Characteristics

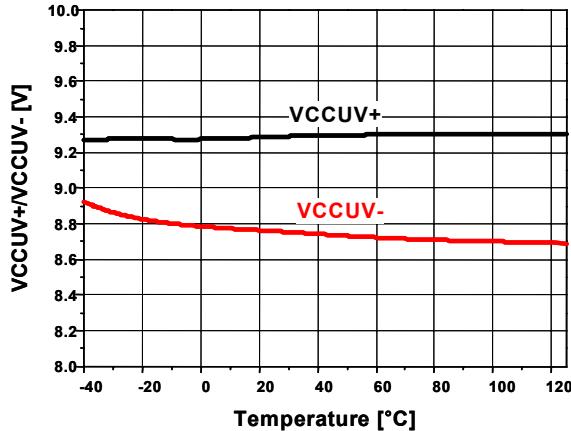


Fig. 25 VCC UVLO Threshold Voltage vs. Temperature

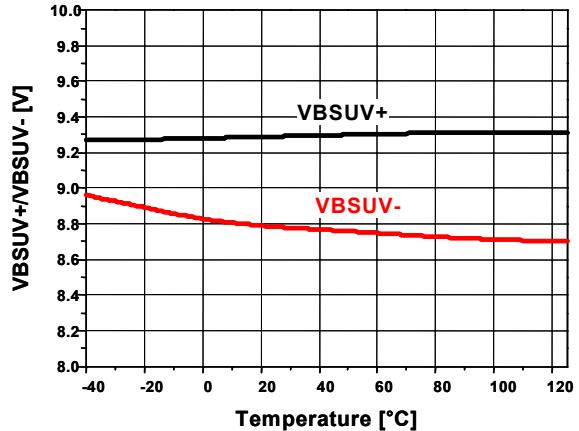


Fig. 26 VBS UVLO Threshold Voltage vs. Temperature

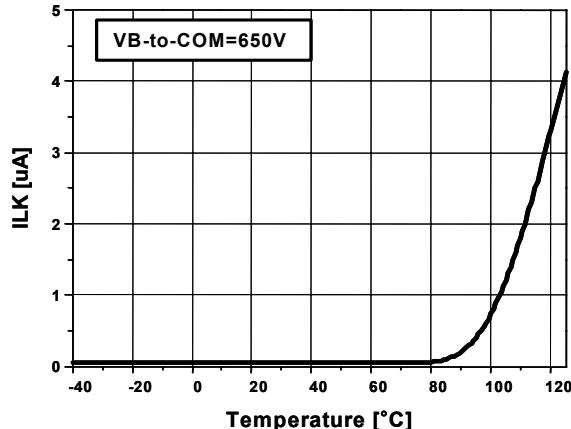


Fig. 27 VB to COM Leakage Current vs. Temperature

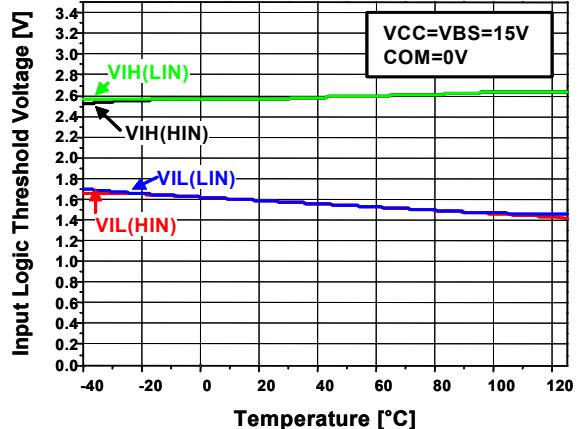


Fig. 28 Input Logic Threshold vs. Temperature

## Typical Characteristics

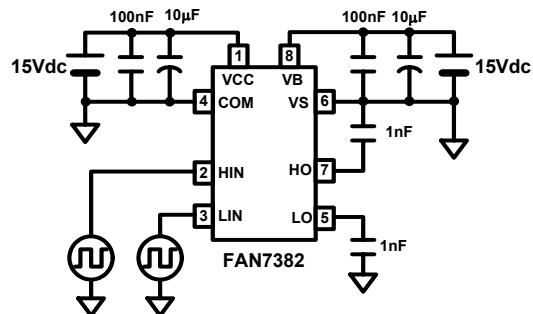


Fig. 29 Switching Time Test Circuit

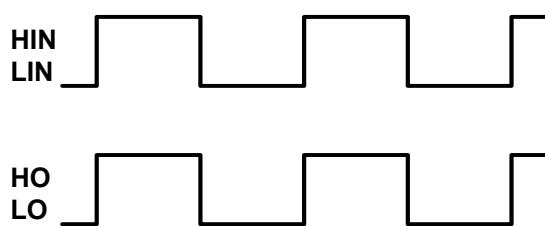


Fig. 30 Input / Output Timing Diagram

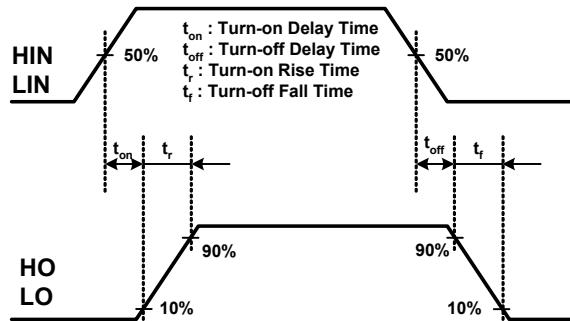


Fig. 31 Switching Time Waveform Definitions

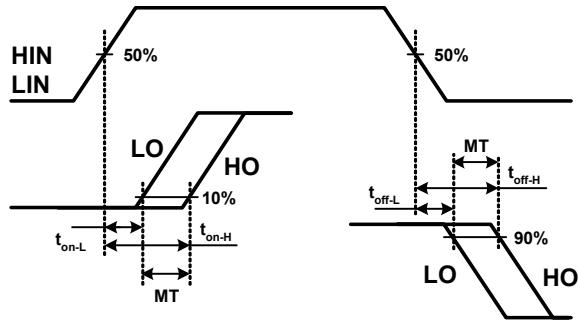
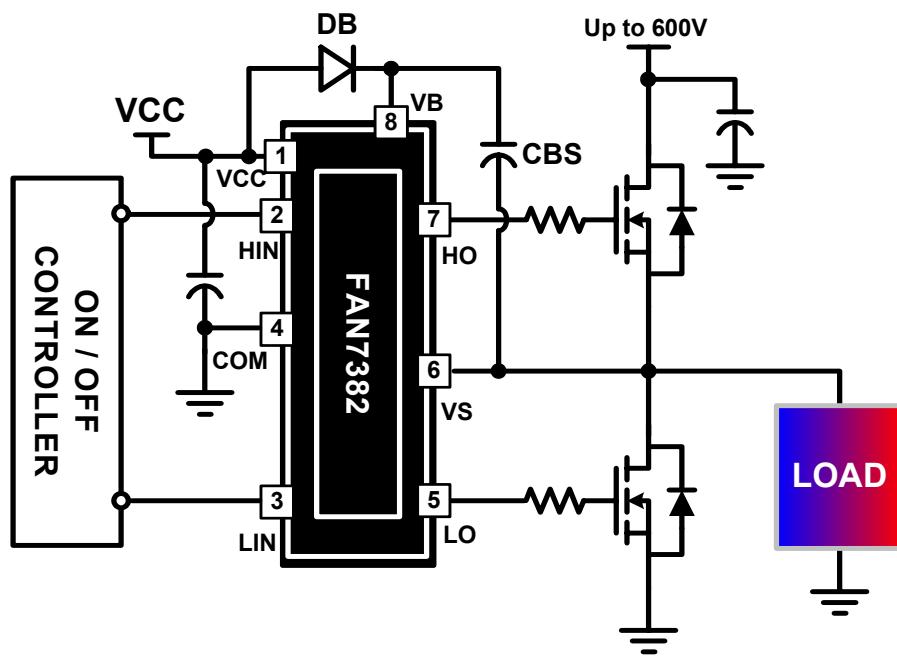


Fig. 32 Delay Matching Waveform Definition

**Typical Application Circuit**

## Mechanical Dimensions

### Package

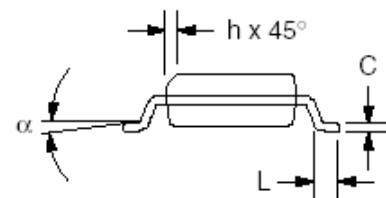
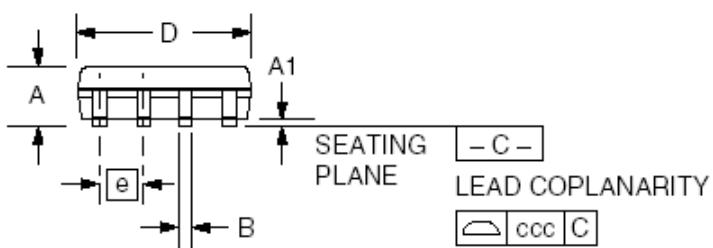
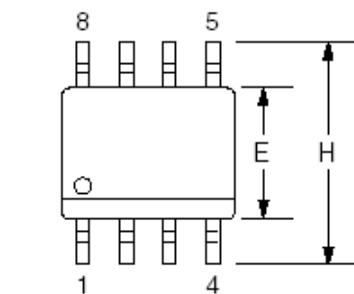
Dimensions in millimeters

### 8-SOP

Symbol	Inches		Millimeters		Notes
	Min.	Max.	Min.	Max.	
A	.053	.069	1.35	1.75	
A1	.004	.010	0.10	0.25	
B	.013	.020	0.33	0.51	
C	.0075	.010	0.20	0.25	5
D	.189	.197	4.80	5.00	2
E	.150	.158	3.81	4.01	2
e	.050 BSC		1.27 BSC		
H	.228	.244	5.79	6.20	
h	.010	.020	0.25	0.50	
L	.016	.050	0.40	1.27	3
N	8		8		6
$\alpha$	$0^\circ$	$8^\circ$	$0^\circ$	$8^\circ$	
ccc	—	.004	—	0.10	

#### Notes:

1. Dimensioning and tolerancing per ANSI Y14.5M-1982.
2. "D" and "E" do not include mold flash. Mold flash or protrusions shall not exceed .010 inch (0.25mm).
3. "L" is the length of terminal for soldering to a substrate.
4. Terminal numbers are shown for reference only.
5. "C" dimension does not include solder finish thickness.
6. Symbol "N" is the maximum number of terminals.



## Ordering Information

Device	Package	Operating Temperature	Packing
FAN7382M	8SOIC	-40°C ~ +125°C	Tube
FAN7382MX			Tape & Reel

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